



## UNITED STATES PATENT AND TRADEMARK OFFICE

COMMISSIONER FOR PATENTS  
UNITED STATES PATENT AND TRADEMARK OFFICE  
WASHINGTON, D.C. 20231  
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Bib Data Sheet

CONFIRMATION NO. 7610

<b>SERIAL NUMBER</b> 09/848,109	<b>FILING DATE</b> 05/02/2001 <b>RULE</b>	<b>CLASS</b> 714	<b>GROUP ART UNIT</b> 2184	<b>ATTORNEY DOCKET NO.</b> 3123-355
<b>APPLICANTS</b> Curtis W. Egan, Thornton, CO; Steve McCarthy, Mead, CO;				
<b>** CONTINUING DATA *****</b> THIS APPLN CLAIMS BENEFIT OF 60/203,085 05/09/2000				
<b>** FOREIGN APPLICATIONS *****</b>				
<b>IF REQUIRED, FOREIGN FILING LICENSE</b> <b>GRANTED ** 07/03/2001</b>				
Foreign Priority claimed <input type="checkbox"/> yes <input type="checkbox"/> no 35 USC 119 (a-d) conditions met <input type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance		<b>STATE OR COUNTRY</b> CO	<b>SHEETS DRAWING</b> 8	<b>TOTAL CLAIMS</b> 26
Verified and Acknowledged Examiner's Signature _____ Initials _____		<b>INDEPENDENT CLAIMS</b> 4		
<b>ADDRESS</b> Bradley M. Knepper SHERIDAN ROSS P.C. 1560 Broadway, Suite 1200 Denver, CO 80202-5141				
<b>TITLE</b> Method and apparatus for the detection of multiple small defects in a flaw scan detection system				
<b>FILING FEE RECEIVED</b> 898	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:		<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees ( Filing ) <input type="checkbox"/> 1.17 Fees ( Processing Ext. of time ) <input type="checkbox"/> 1.18 Fees ( Issue ) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit	



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				<b>INDEPENDENT CLAIMS</b> 4
<b>ADDRESS</b> TEJPAL S. HANSRA HANSRA PATENT SERVICES 3705 CANTERBURY LANE, #6 #22442 BELLINGHAM, WA 98225				
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